Searc	ch N	lotes
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Application/Control No.	Applicant(s)/Patent und Reexamination	er
10/764,935	ST. JOHN ET AL.	
Examiner	Art Unit	
Dannia Candrai	1721	

SEARCHED			
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INTERFERENCE SEARCHED			
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
Inventor search-PALM	4/20/2006	DRC
IDS and other references-EAST-see search history printout	4/20/2006	DRC
162/158,164.6,166,168.1,168.2,168.3, DIG.4-cursory	4/20/2006	DRC
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text limited search-EAST-see search history printout	4/20/2006	DRC
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